

APPROVAL SHEET

WLPN606028 Series Shielded SMD Power Inductors

*Contents in this sheet are subject to change without prior notice.

Features

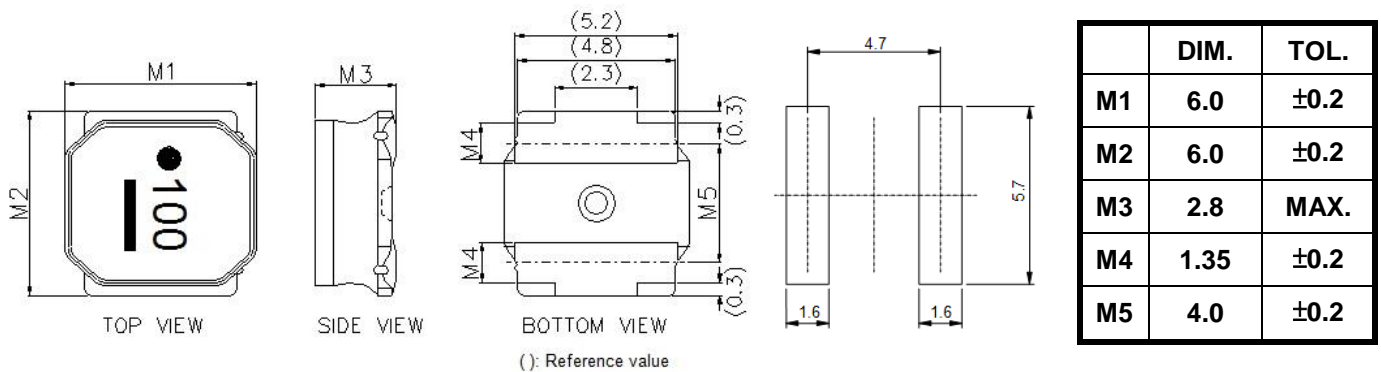
1. Close magnetic loop with magnetic resin shielded.
2. Low profile, High inductance.

Applications

1. General propose power inductor in DC power system.
2. Inductor in DC/DC converter.
3. Low profile for portable and wearable device.
4. LC filter in Audio D class Amplifier.

Shape and Dimension

Unit: mm



Ordering Information

WL	PN	6060	28	N	1R5	L	B
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	Shielded SMD Power Inductors	6.0 * 6.0 mm	2.8 mm	M: ± 20% N: ± 30%	R90 = 0.9uH 1R5 = 1.5uH 100 = 10uH	L=13" Reeled (Embossed Tape)	B:STD

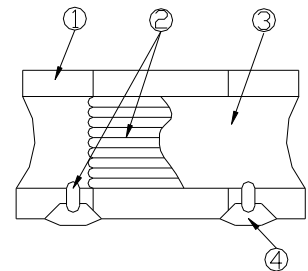
Electrical Characteristics

WLPN606028 Series	L (μ H)	Inductance Tolerance	Test Freq (KHz)	DCR ($\Omega \pm 30\%$)	SRF (MHz)Min	Rated Current (mA) Max	
						Saturation Current Idc1	Temperature Rise Current Idc2
WLPN606028NR90LB	0.9	N	100	0.013	90	6700	4600
WLPN606028N1R5LB	1.5	N	100	0.016	78	5100	4200
WLPN606028N2R2LB	2.2	N	100	0.02	68	4200	3700
WLPN606028N3R0LB	3	N	100	0.023	55	3600	3400
WLPN606028M4R7LB	4.7	M	100	0.031	39	2700	3000
WLPN606028M6R0LB	6	M	100	0.04	30	2500	2500
WLPN606028M100LB	10	M	100	0.065	20	1900	1900
WLPN606028M150LB	15	M	100	0.095	17	1600	1800
WLPN606028M220LB	22	M	100	0.135	12	1300	1400
WLPN606028M330LB	33	M	100	0.22	10	1100	1100
WLPN606028M470LB	47	M	100	0.3	8	1000	920
WLPN606028M680LB	68	M	100	0.42	5	800	770
WLPN606028M101LB	100	M	100	0.6	3	650	660

1. Test Frequency: 100KHz.
2. Test Equipment:
Inductance: Chroma3302+1320+16502 or equivalent.
DCR: Chroma16502 or equivalent.
SRF: HP4291B or equivalent.
3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.
4. Temperature rise current Idc2: The value of current causes a 40°C temperature rise.
5. Rated Current: Either Idc1 or Idc2 whichever is smaller.
6. Operating Temperature Range:-25°C to +125°C (Including self-temperature rise).
7. Storage Temp. Range : -40°C to +85°C.
8. MSL : Level 1.

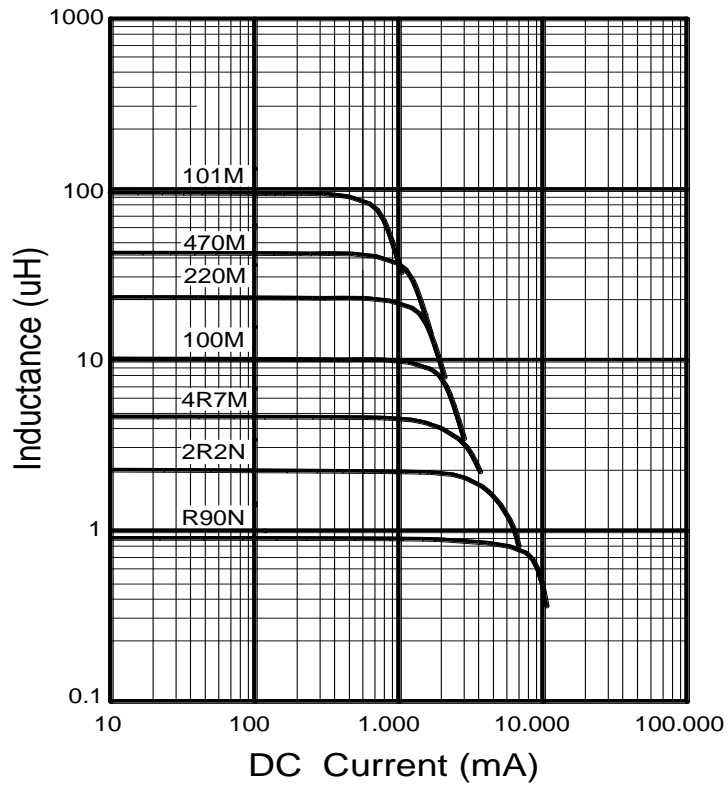
Structural Drawing

- ① Ferrite core : Ni-Zn ferrite.
- ② Winding wire : Polyurethane-copper wire.
- ③ Over-coating resin : Epoxy resin, containing ferrite powder.
- ④ Electrode : External electrode (substrate) Ag
External electrode (base plating) Ni-Sn
External electrode (top surface solder coating) Sn-Ag-Cu



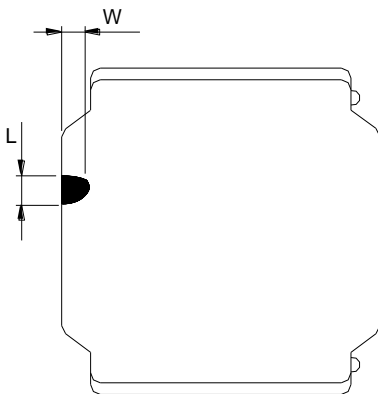
Characteristic Curve

Inductance vs. DC Current



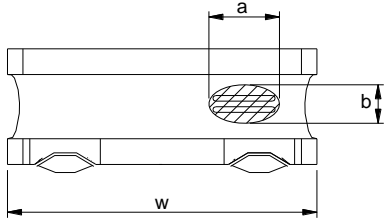
Core Chipping:

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.



L	W
1.5mmMax.	1.5mmMax.

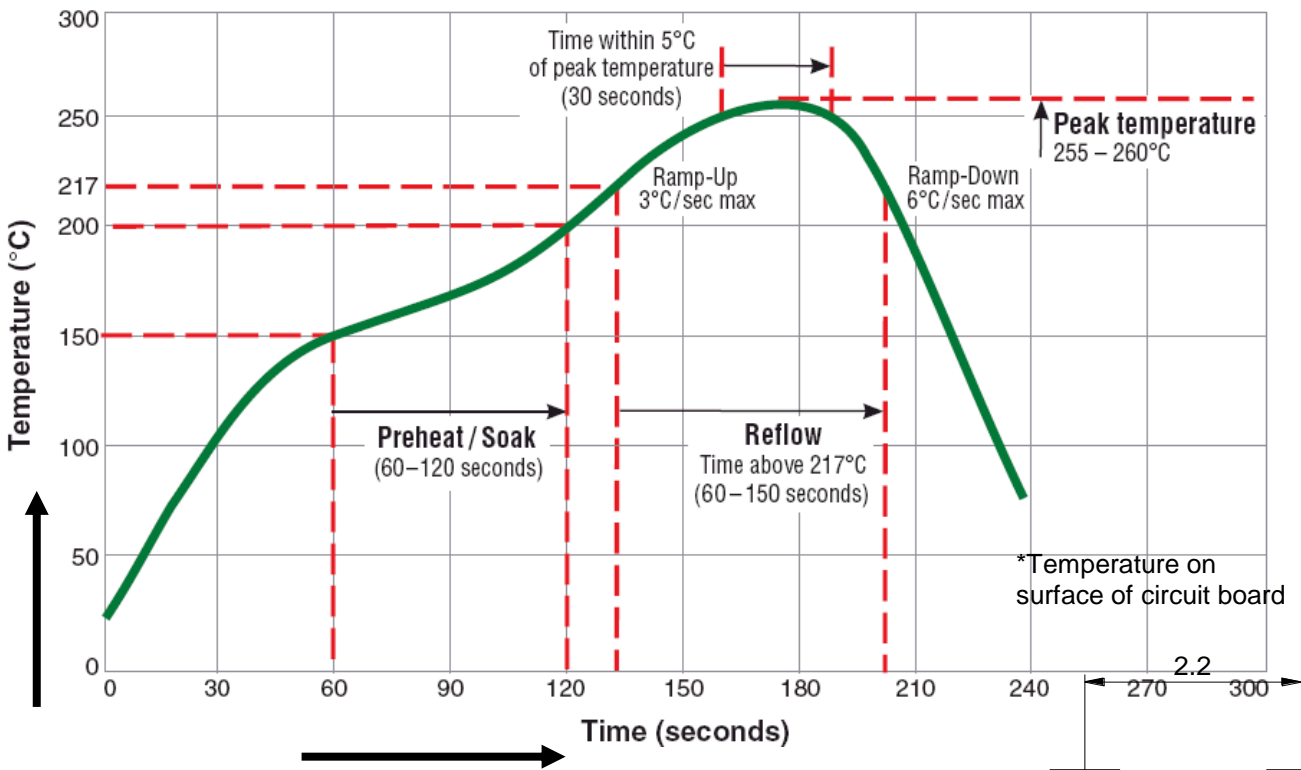
Exposed wire tolerance limit of coating resin part on product side
Size of exposed wire occurring to coating resin is specified below.



- ① Width direction (dimension a): Acceptable when $a \leq w/2$
 Nonconforming when $a > w/2$
- ② Length direction (dimension b): Dimension b is not specified.
- ③ When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

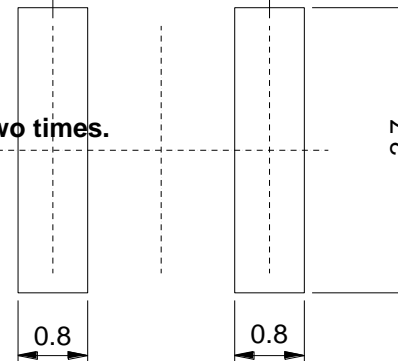
Reflow Profile Chart (Reference):

Typical RoHS Reflow Profile

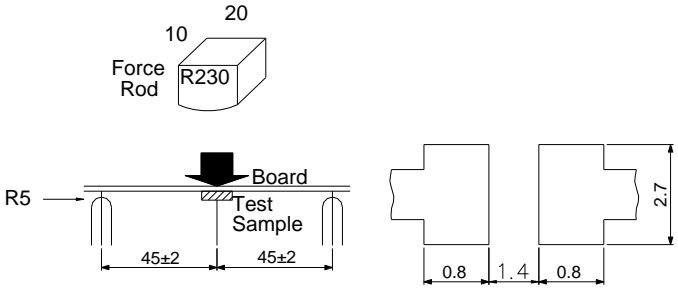
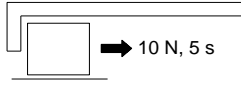
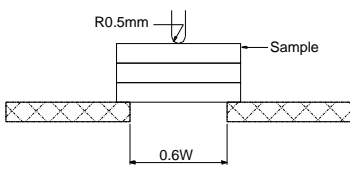


(Table 1)

The products may be exposed to reflow soldering process of above profile up to two times.



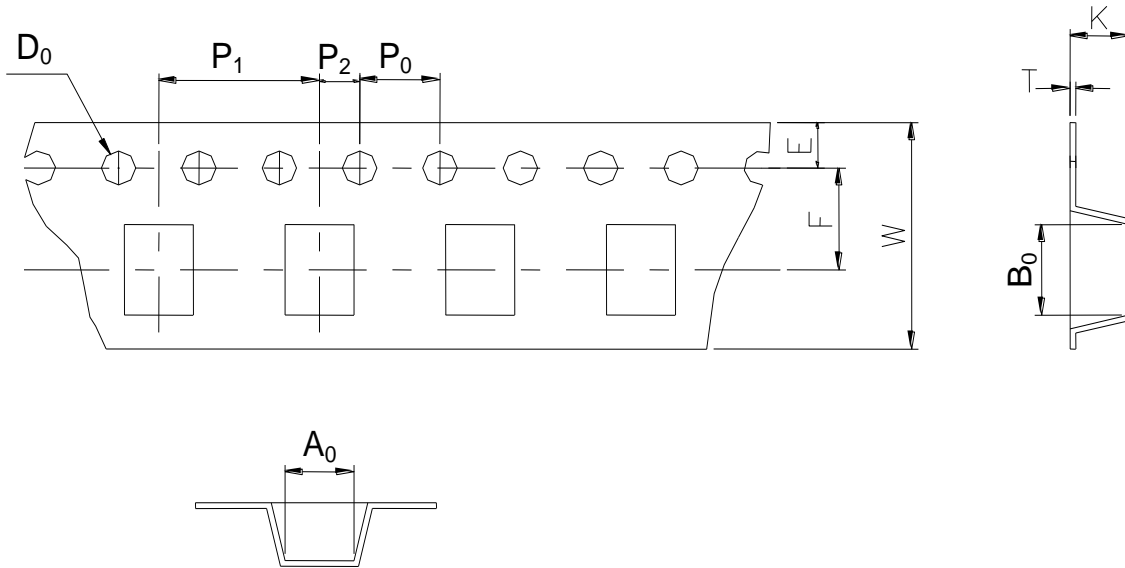
Mechanical Performance /Environmental Test Performance Specifications:

No.	Item	Test condition	Requirements								
1	Resistance to Deflection.	No damage.	<p>The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicating until deflection of the test board Reaches to 2 mm.</p>  <p>Force Rod R230 10 20</p> <p>Board Test Sample 45±2 45±2</p> <p>Land dimensions Unit: mm 0.8 1.4 0.8 2.7</p> <p>Test board size :100×40×10 Test board material I: glass epoxy-resin Solder cream thickness:0.1</p>								
2	Adhesion of Terminal Electrode.	Shall not come off PC board	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</p>  <p>10 N, 5 s</p> <p>Applied force: 10 N to X and Y directions Duration: 5 s. Solder cream thickness:0.1 mm. (Refer to recommended Land Pattern Dimensions Defined in "Precaution")</p>								
3	Body strength.	No damage	<p>Applied force :20 N. Duration :10 s.</p>  <p>R0.5mm Sample 0.6W</p>								
4	Resistance to Vibration.	<p>△L/L:within±10% No abnormality observed In appearance</p>	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. Then it shall be submitted to below test conditions.</p> <table border="1" data-bbox="673 1594 1412 1751"> <tr> <td>Frequency range</td> <td>10Hz~55Hz</td> </tr> <tr> <td>Total Amplitude</td> <td>1.5mm(May not exceed acceleration 196 m/S2)</td> </tr> <tr> <td>Sweeping Method</td> <td>10Hz to 55Hz to 10 Hz for 1 min.</td> </tr> <tr> <td>Time</td> <td>For 2 hours on each X, Y, and Z axis.</td> </tr> </table>	Frequency range	10Hz~55Hz	Total Amplitude	1.5mm(May not exceed acceleration 196 m/S2)	Sweeping Method	10Hz to 55Hz to 10 Hz for 1 min.	Time	For 2 hours on each X, Y, and Z axis.
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Time	For 2 hours on each X, Y, and Z axis.										
5	Resistance to Soldering heat (Reflow).	<p>△L/L:within±10% No abnormality observed In appearance</p>	<p>The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times.</p> <p>Test board thickness:1.0 mm Test board material :glass epoxy-resin</p>								

6	Solder ability.	At least 90% of surface of terminal electrode is covered by new solder.	<p>The test samples shall be dipped in flux, and then Immersed in molten solder as shown in below table.</p> <p>Flux: Methanol solution containing rosin 25%</p> <table border="1"> <tr> <td>Solder Temperature</td> <td>245±deg C</td> </tr> <tr> <td>Time</td> <td>5±1.0 S.</td> </tr> <tr> <td>Immersing Speed</td> <td>25 mm/s</td> </tr> </table>	Solder Temperature	245±deg C	Time	5±1.0 S.	Immersing Speed	25 mm/s									
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Time	5±1.0 S.																	
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7	Temperature Characteristics.	△L/L:within±20% No abnormality observed In appearance	<p>Measurement of inductance shall be taken at temperature range within -25 deg C to +85 deg C.</p> <p>With reference to inductance value at +20 deg C, change rate shall be calculated.</p>															
8	Thermal shock.	△L/L:within±10% No abnormality observed in appearance.	<p>The test samples shall be soldered to test board by the reflow soldering conditions shown in Table 1.</p> <p>The test samples shall be placed at specified shown in below table in sequence.</p> <p>The temperature cycle shall be repeated 100 cycles.</p> <p>Conditions of steps for 1 cycle.</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature</th> <th>Time(min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>-40±3 deg C</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp</td> <td>3 maximum</td> </tr> <tr> <td>3</td> <td>85±2 deg C</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp</td> <td>3 maximum</td> </tr> </tbody> </table>	Step	Temperature	Time(min)	1	-40±3 deg C	30±3	2	Room Temp	3 maximum	3	85±2 deg C	30±3	4	Room Temp	3 maximum
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3	85±2 deg C	30±3																
4	Room Temp	3 maximum																
9	Low Temperature life Test.	△L/L:within±10% No abnormality observed in appearance.	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</p> <p>After that, the test samples shall be placed at test conditions as shown in below table.</p> <table border="1"> <tr> <td>Temperature</td> <td>-40±2 deg C</td> </tr> <tr> <td>Time</td> <td>500 +24/-0 h</td> </tr> </table>	Temperature	-40±2 deg C	Time	500 +24/-0 h											
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10	Loading at high temperature life test.	△L/L:within±10% No abnormality observed in appearance.	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</p> <p>The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table.</p> <table border="1"> <tr> <td>Temperature</td> <td>85±2 deg C</td> </tr> <tr> <td>Applied current</td> <td>Rated current (Refer to Page 3)</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	85±2 deg C	Applied current	Rated current (Refer to Page 3)	Time	500+24/-0 h									
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Applied current	Rated current (Refer to Page 3)																	
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11	Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</p> <p>The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below table.</p> <table border="1"> <tr> <td>Temperature</td> <td>60±2 deg C</td> </tr> <tr> <td>Humidity</td> <td>90~95%RH</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	60±2 deg C	Humidity	90~95%RH	Time	500+24/-0 h									
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12	Loading under Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	<p>The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.</p> <p>The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.</p> <table border="1"> <tr> <td>Temperature</td> <td>60±2 deg C</td> </tr> <tr> <td>Humidity</td> <td>90~95%RH</td> </tr> <tr> <td>Applied current</td> <td>Rated current (Refer to Page 3)</td> </tr> <tr> <td>Time</td> <td>500+24/-0 h</td> </tr> </table>	Temperature	60±2 deg C	Humidity	90~95%RH	Applied current	Rated current (Refer to Page 3)	Time	500+24/-0 h							
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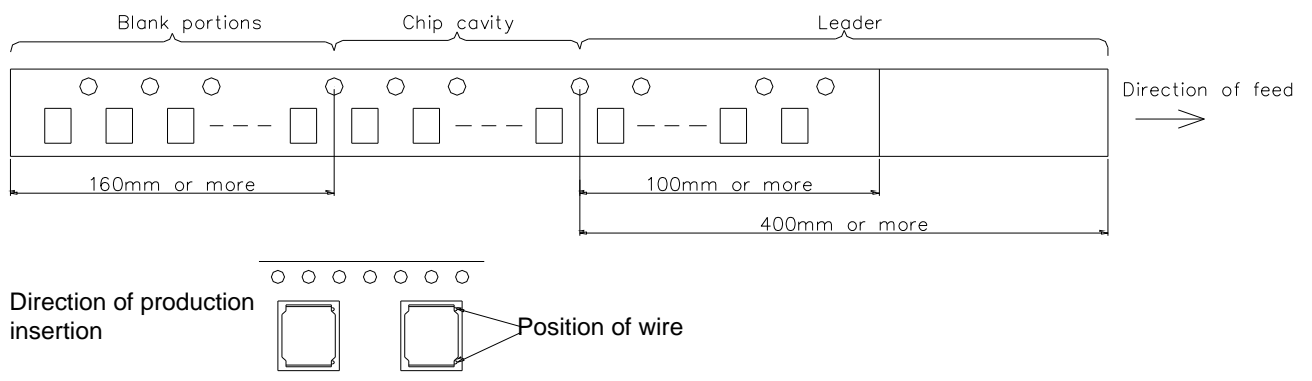
Tape & Reel Packaging Dimensions:

Dimensions Unit: mm

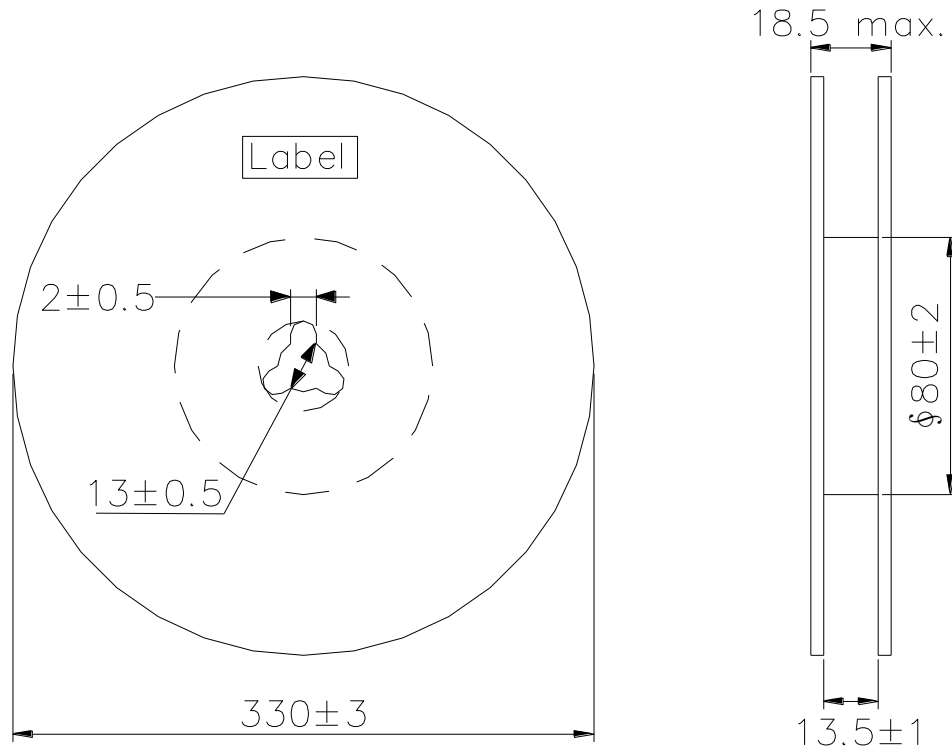


A_0	B_0	W	F	E	P_1	P_2	P_0	D_0	T	K
6.30 ± 0.1	6.30 ± 0.1	12.0 ± 0.3	5.5 ± 0.1	1.75 ± 0.1	8.0 ± 0.1	2.0 ± 0.1	4.0 ± 0.1	$\Phi 1.5$ $+0.1$ -0	0.40 ± 0.1	3.10 ± 0.1

Direction of rolling

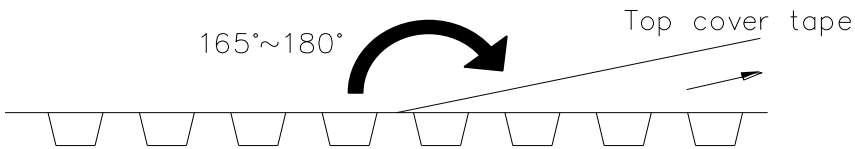


Reel



Label position: on the opposite side of sprocket holes side of reel

Top tape strength



Peel-off strength: 0.1N~1.3N

Peel-off angle: $165^\circ \sim 180^\circ$

Peel-off speed: 300mm/mm

Quantity per reel : 2K pcs